

## Automotive MOSFET OptiMOS™ 7 Power-Transistor

### Features

- OptiMOS™ power MOSFET for automotive applications
- N-channel - Enhancement mode - Normal Level
- Extended qualification beyond AEC-Q101
- Enhanced electrical testing
- Robust design
- MSL2a up to 260°C peak reflow
- 175°C operating temperature
- RoHS compliant
- 100% Avalanche tested

### Potential applications

General automotive applications.

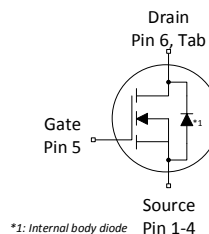
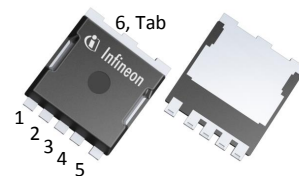
### Product validation

Qualified according to Automotive applications.  
Product validation according to AEC-Q101.

**Table 1** Key performance parameters

Parameter	Value	Unit
$V_{DS}$	40	V
$R_{DS(on)}$	1.43	mΩ
$I_D$ (chip limited)	182	A

PG-HSOF-5



Part number	Package	Marking	Related links
IAUAN04S7N014	PG-HSOF-5	7N04N014	see Appendix A

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## 1 Maximum ratings

at  $T_j=25\text{ °C}$ , unless otherwise specified

**Table 2 Maximum ratings**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Continuous drain current	$I_D$	-	-	182	A	Chip limitation, $V_{GS} = 10\text{ V}$ <sup>1) 2)</sup>
				160		DC current, $V_{GS} = 10\text{ V}$
				34		$R_{thJA}$ on 2s2p, $V_{GS} = 10\text{ V}$ , $T_a = 100\text{ °C}$ <sup>1)</sup>
Pulsed drain current <sup>1)</sup>	$I_{D,pulse}$	-	-	520	A	$T_C = 25\text{ °C}$ , $t_p = 100\text{ }\mu\text{s}$
Avalanche energy, single pulse <sup>1)</sup>	$E_{AS}$	-	-	69	mJ	$I_D = 50\text{ A}$
Avalanche current, single pulse	$I_{AS}$	-	-	100	A	-
Gate source voltage	$V_{GS}$	-20	-	20	V	-
Power dissipation	$P_{tot}$	-	-	90	W	$T_C = 25\text{ °C}$
Operating temperature	$T_j$	-55	-	175	°C	-

<sup>1)</sup> The parameter is not subject to production testing - specified by design.

<sup>2)</sup> In practice, the current is limited by the overall system design, including the customer-specific PCB.

## 2 Thermal characteristics

**Table 3 Thermal characteristics**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case 3)	$R_{thJC}$	-	-	1.66	K/W	-
Thermal resistance, junction - ambient <sup>4) 3)</sup>	$R_{thJA}$	-	24.2	-		

3) The parameter is not subject to production testing - specified by design.

4) Device on 2s2p FR4 PCB defined in accordance with JEDEC standards (JESD51-5, -7). PCB is vertical in still air.

## 3 Electrical characteristics

at  $T_j=25\text{ °C}$ , unless otherwise specified

**Table 4 Static characteristics**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Drain-source breakdown voltage	$V_{(BR)DSS}$	40	-	-	V	$I_D = 1\text{ mA}$ , $V_{GS} = 0\text{ V}$
Gate threshold voltage	$V_{GS(th)}$	2.2	2.6	3	V	$V_{DS}=V_{GS}$ , $I_D = 35\text{ }\mu\text{A}$
Zero gate voltage drain current	$I_{DSS}$	-	-	1	$\mu\text{A}$	$V_{DS} = 40\text{ V}$ , $T_J = 25\text{ °C}$ , $V_{GS} = 0\text{ V}$
				9		$V_{DS} = 40\text{ V}$ , $T_J = 100\text{ °C}$ , $V_{GS} = 0\text{ V}$ <sup>5)</sup>
Gate-source leakage current	$I_{GSS}$	-	-	100	nA	$V_{DS} = 0\text{ V}$ , $V_{GS} = 20\text{ V}$
Drain-source on-state resistance	$R_{DS(on)}$	-	1.57	1.86	m $\Omega$	$I_D = 40\text{ A}$ , $V_{GS} = 7\text{ V}$
			1.22	1.43		$I_D = 80\text{ A}$ , $V_{GS} = 10\text{ V}$
Gate resistance <sup>5)</sup>	$R_G$	-	1.6	-	$\Omega$	-

5) The parameter is not subject to production testing - specified by design.

**Table 5 Dynamic characteristics**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Input capacitance <sup>6)</sup>	$C_{iss}$	-	2260	2930	pF	$V_{DS} = 20\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$
Output capacitance <sup>6)</sup>	$C_{oss}$		1320	1710		
Reverse transfer capacitance <sup>6)</sup>	$C_{rss}$		46	69		
Turn-on delay time <sup>6)</sup>	$t_{d(on)}$	-	9	-	ns	$I_D = 80\text{ A}, V_{GS} = 10\text{ V}, V_{DD} = 20\text{ V}, R_G = 3.5\ \Omega$
Rise time <sup>6)</sup>	$t_r$		4			
Turn-off delay time <sup>6)</sup>	$t_{d(off)}$		15			
Fall time <sup>6)</sup>	$t_f$		7			

<sup>6)</sup> The parameter is not subject to production testing - specified by design.

**Table 6 Gate Charge Characteristics**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Gate to source charge <sup>7)</sup>	$Q_{gs}$	-	10	13	nC	$I_D = 80\text{ A}, V_{DS} = 20\text{ V}, V_{GS} = 0\text{ V to } 10\text{ V}$
Gate to drain charge <sup>7)</sup>	$Q_{gd}$		7	11	nC	
Gate charge total <sup>7)</sup>	$Q_g$		33	43	nC	
Gate plateau voltage <sup>7)</sup>	$V_{plateau}$		4.4	-	V	

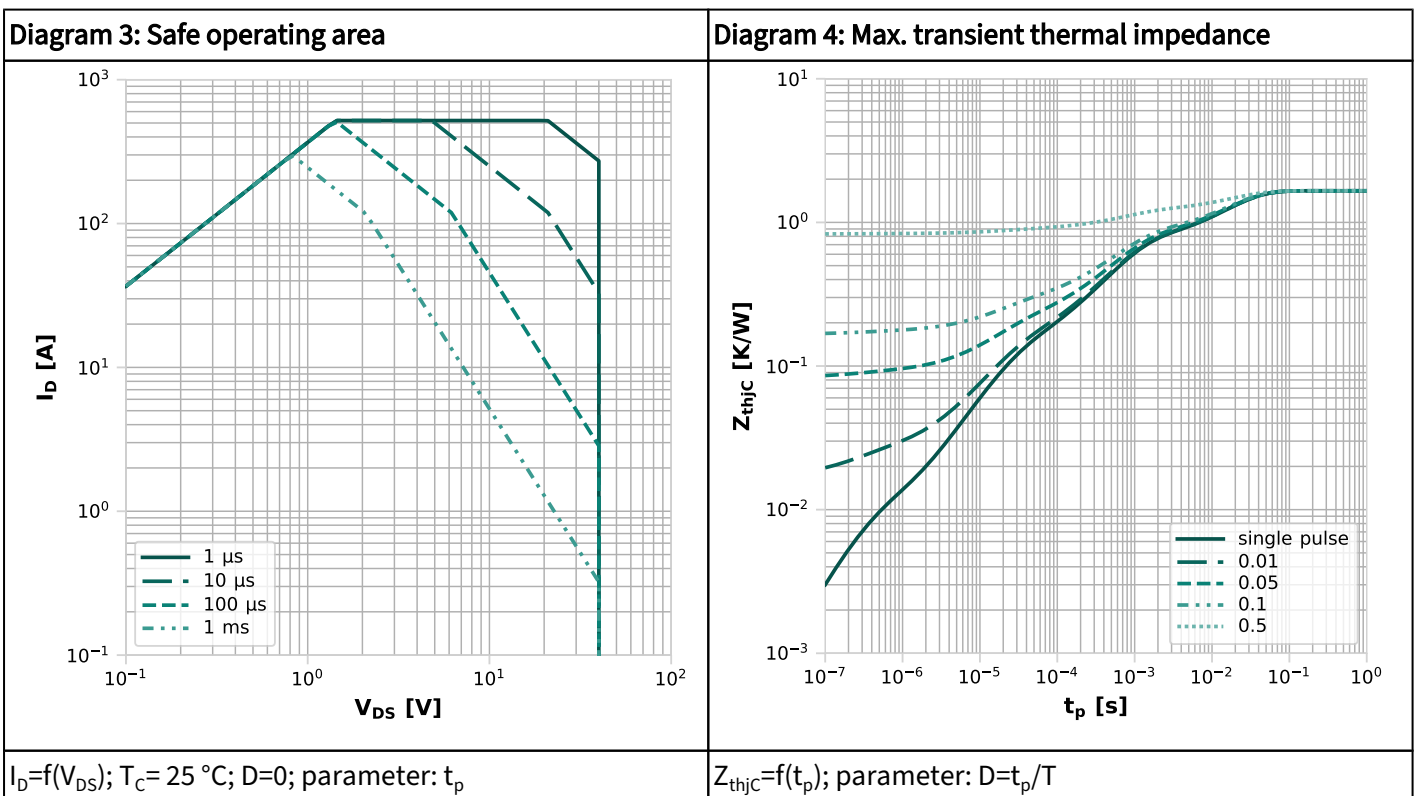
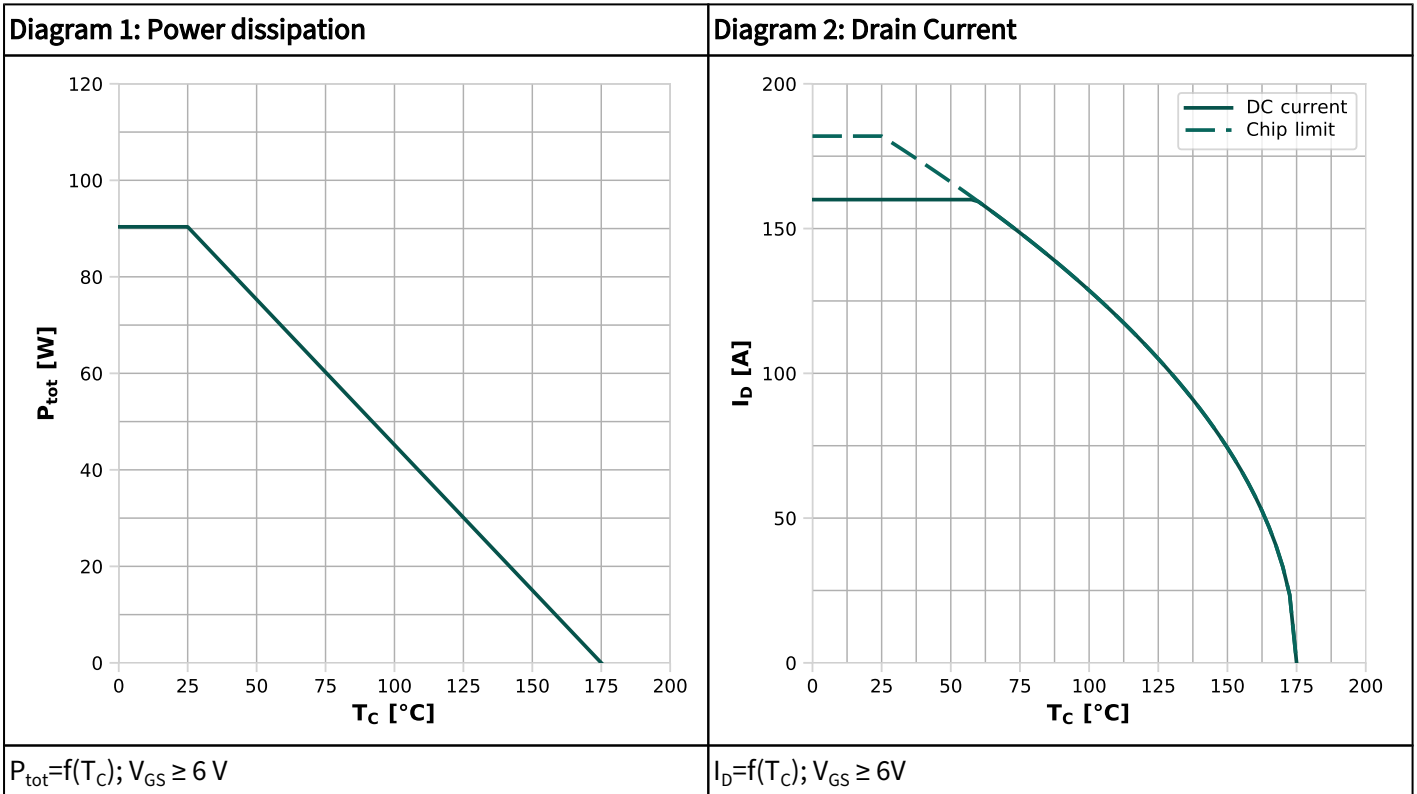
<sup>7)</sup> The parameter is not subject to production testing - specified by design.

**Table 7 Reverse Diode**

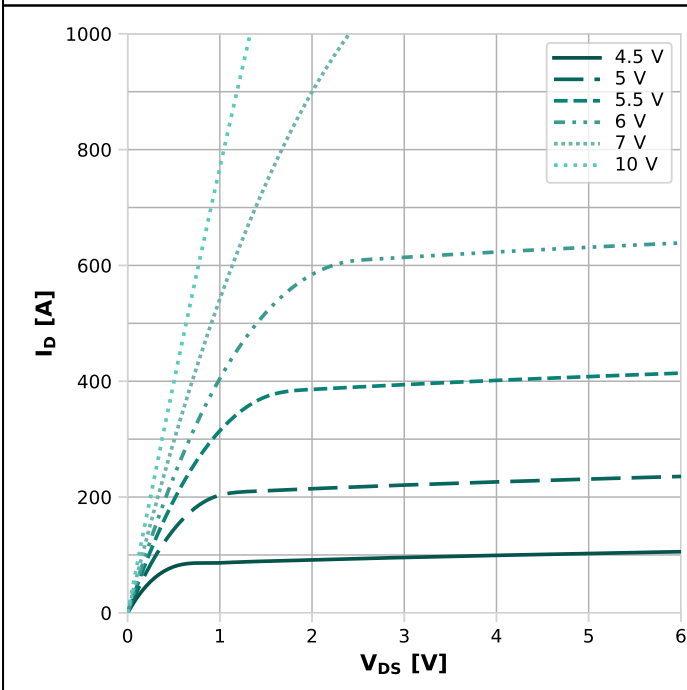
Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Diode continuous forward current	$I_S$	-	-	160	A	$T_C = 25\text{ °C}$ <sup>8)</sup>
Diode pulse current <sup>8)</sup>	$I_{S,pulse}$	-	-	520	A	$T_C = 25\text{ °C}, t_p = 100\ \mu\text{s}$
Diode forward voltage	$V_{SD}$	-	0.85	0.95	V	$T_J = 25\text{ °C}, V_{GS} = 0\text{ V}, I_F = 80\text{ A}$
Reverse recovery time <sup>8)</sup>	$t_{rr}$	-	33	50	ns	$di_F/dt = 100\text{ A}/\mu\text{s}, V_R = 20\text{ V}, I_F = 50\text{ A}$
Reverse recovery charge <sup>8)</sup>	$Q_{rr}$		17	34	nC	

<sup>8)</sup> The parameter is not subject to production testing - specified by design.

## 4 Electrical characteristics diagrams

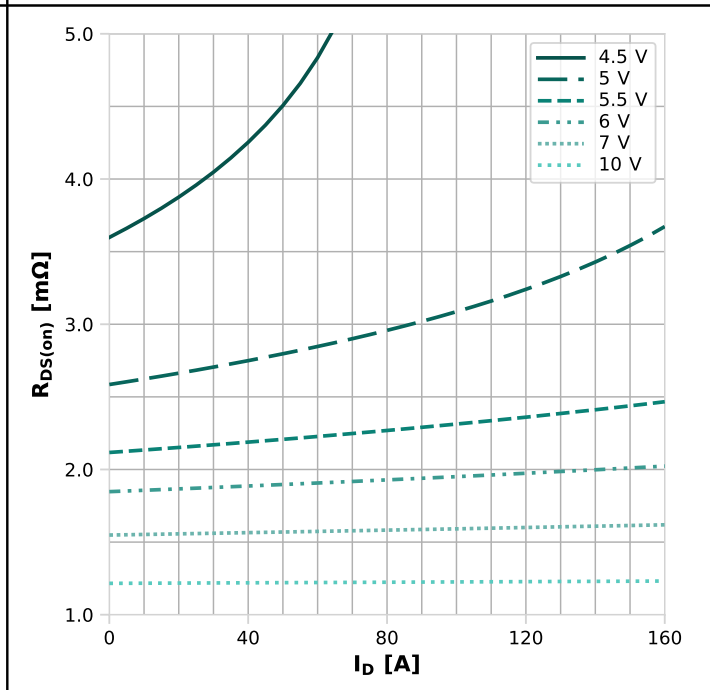


**Diagram 5: Typ. output characteristics**



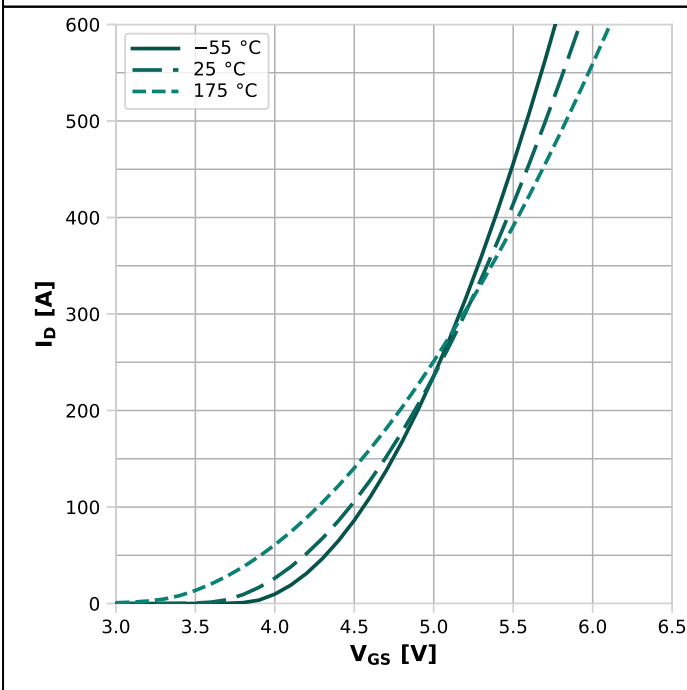
$I_D = f(V_{DS}); T_j = 25\text{ °C}; \text{parameter: } V_{GS}$

**Diagram 6: Typ. drain-source on-state resistance**



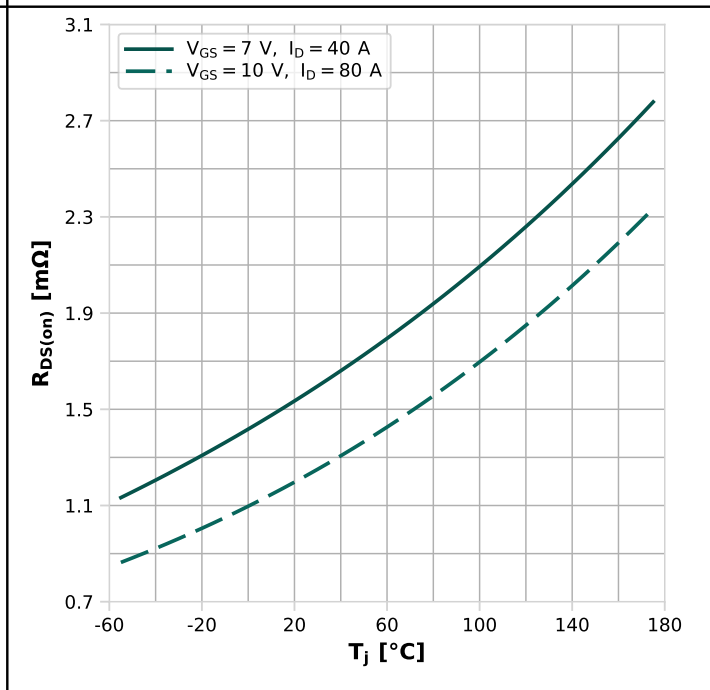
$R_{DS(on)} = f(I_D); T_j = 25\text{ °C}; \text{parameter: } V_{GS}$

**Diagram 7: Typ. transfer characteristics**



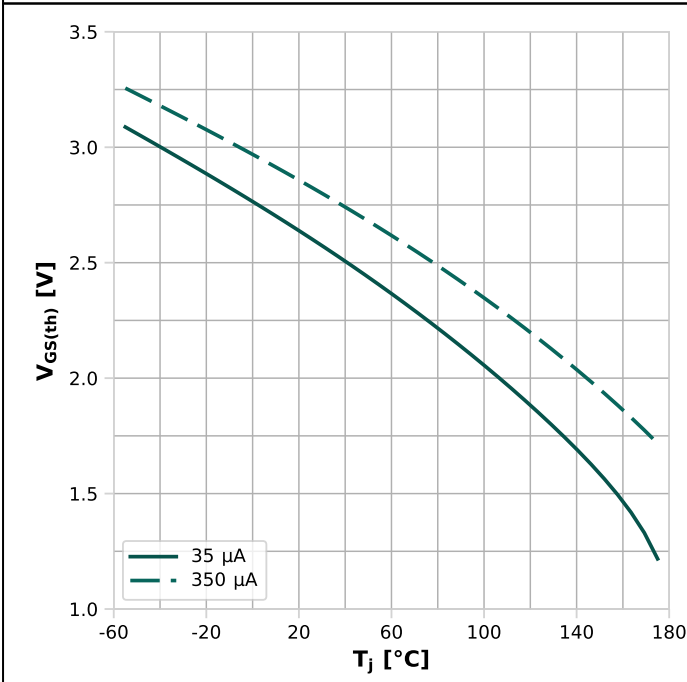
$I_D = f(V_{GS}); V_{DS} = 6\text{ V}; \text{parameter: } T_j$

**Diagram 8: Typ. drain-source on-state resistance**



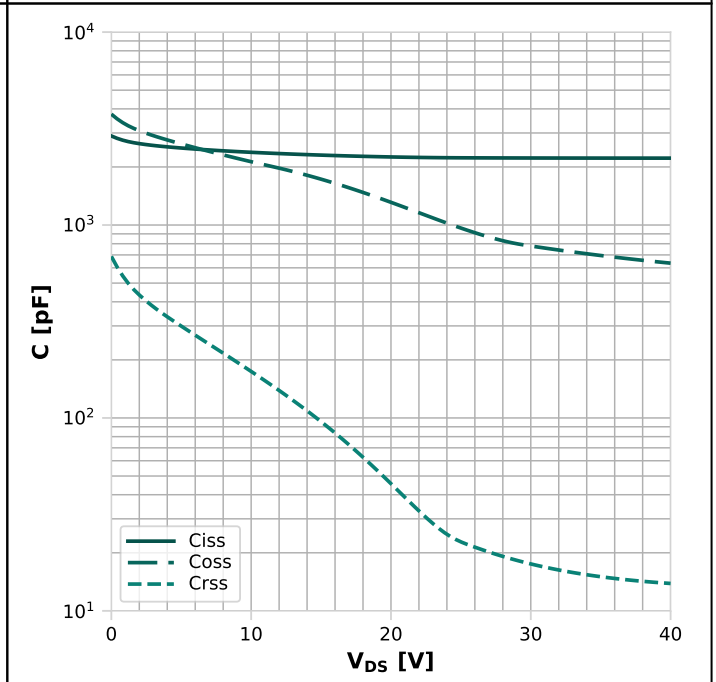
$R_{DS(on)} = f(T_j); \text{parameter: } I_D, V_{GS}$

**Diagram 9: Typ. gate threshold voltage**



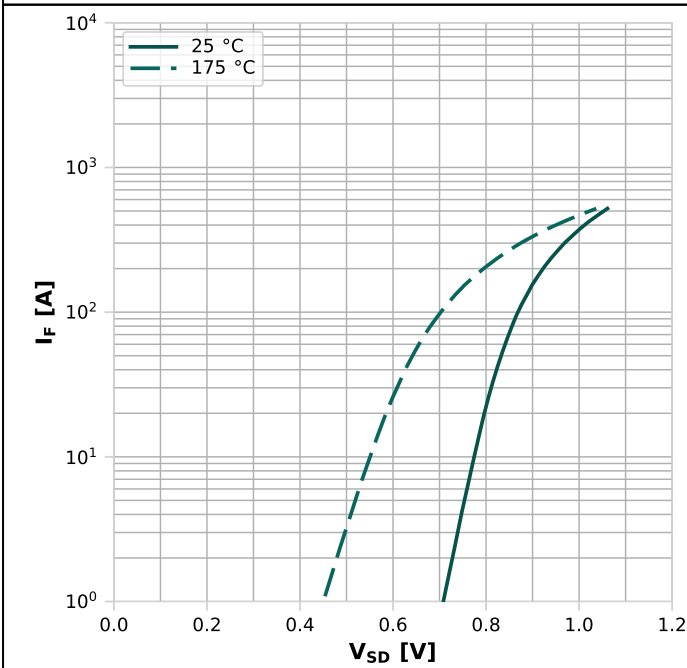
$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}; \text{parameter: } I_D$

**Diagram 10: Typ. capacitances**



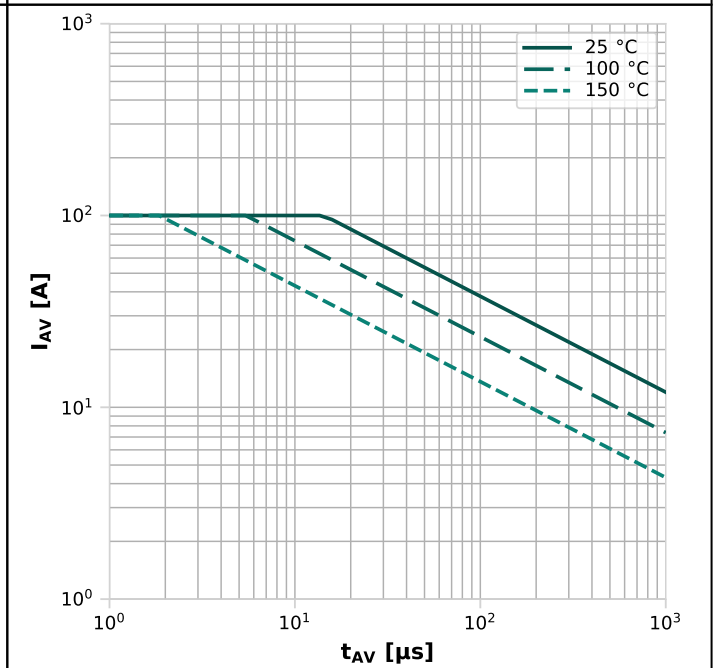
$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$

**Diagram 11: Typ. forward diode characteristics**



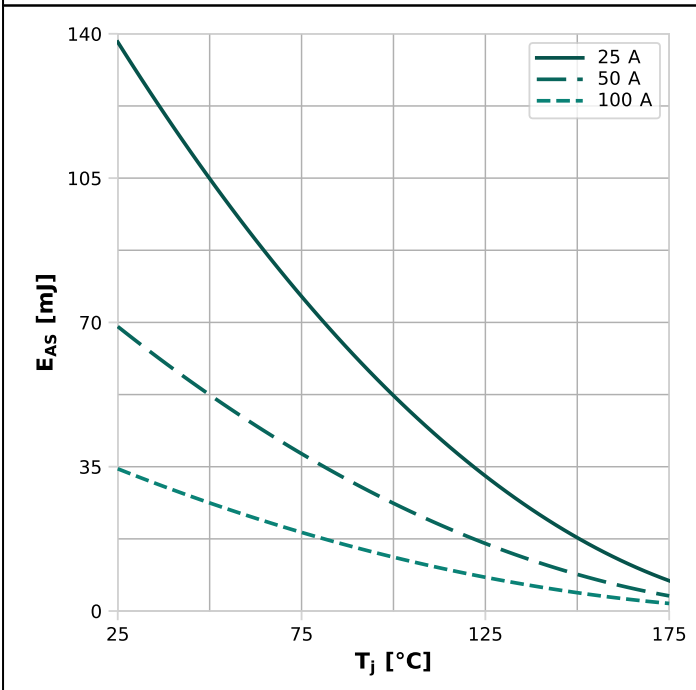
$I_F = f(V_{SD}); \text{parameter: } T_j$

**Diagram 12: Typ. avalanche characteristics**



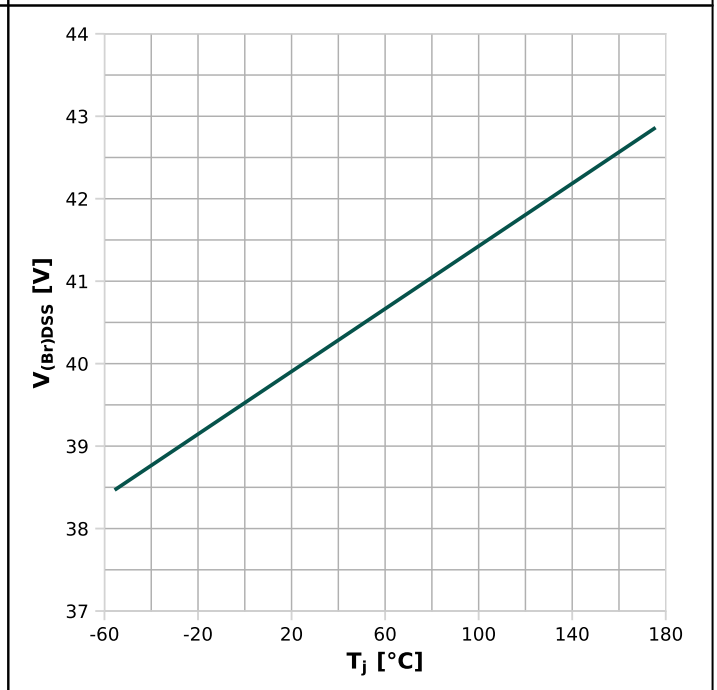
$I_{AS} = f(t_{AV}); \text{parameter: } T_{j(start)}$

**Diagram 13: Typical avalanche Energy**



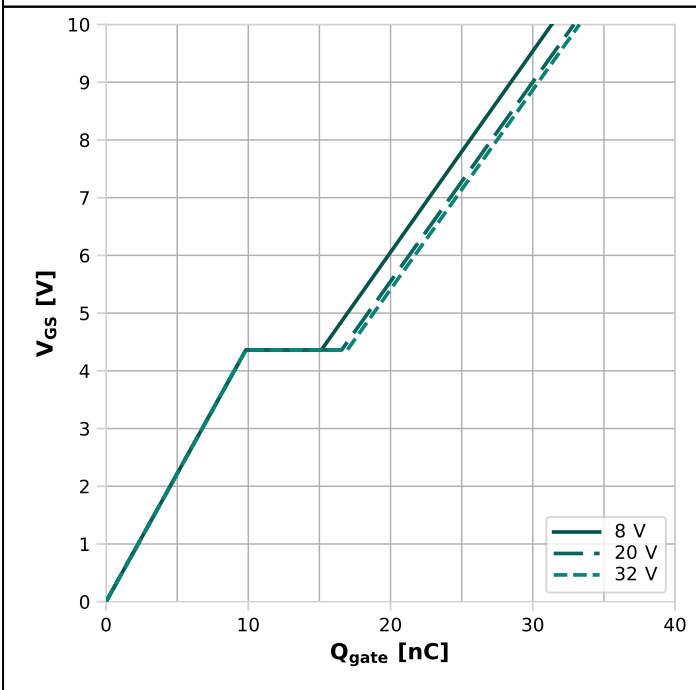
$E_{AS}=f(T_j)$ ; parameter:  $I_D$

**Diagram 14: Drain-source breakdown voltage**



$V_{(Br)DSS}=f(T_j)$ ;  $I_D=1\text{ mA}$

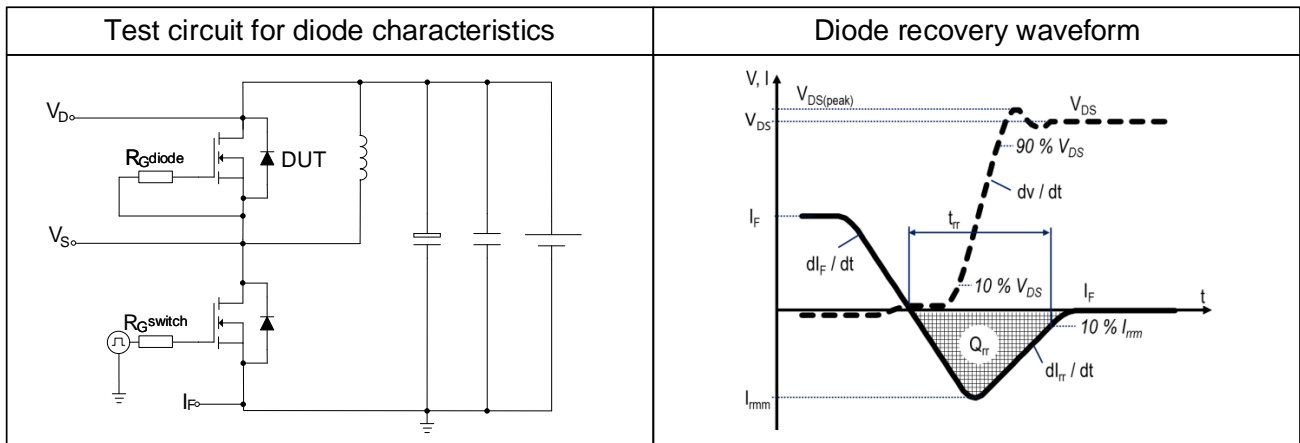
**Diagram 15: Typ. gate charge**



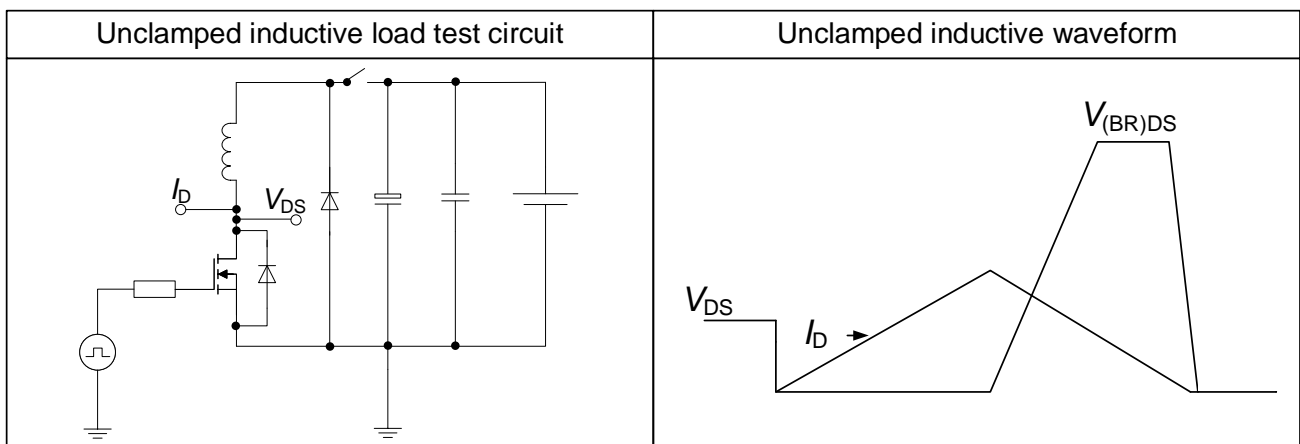
$V_{GS}=f(Q_{gate})$ ;  $I_D=80\text{ A pulsed}$ ; parameter:  $V_{DD}$

## 5 Test circuits

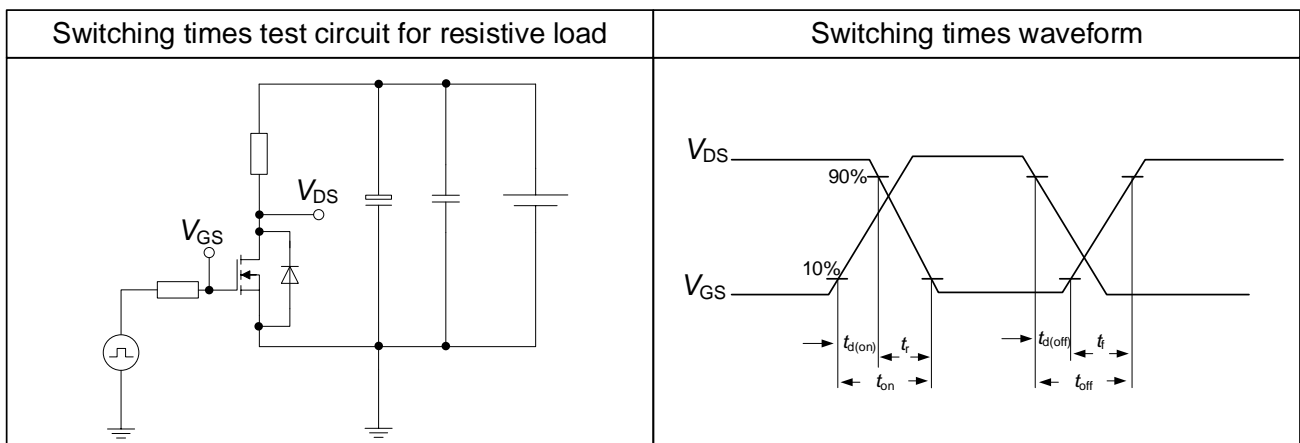
**Table 8 Diode characteristics**



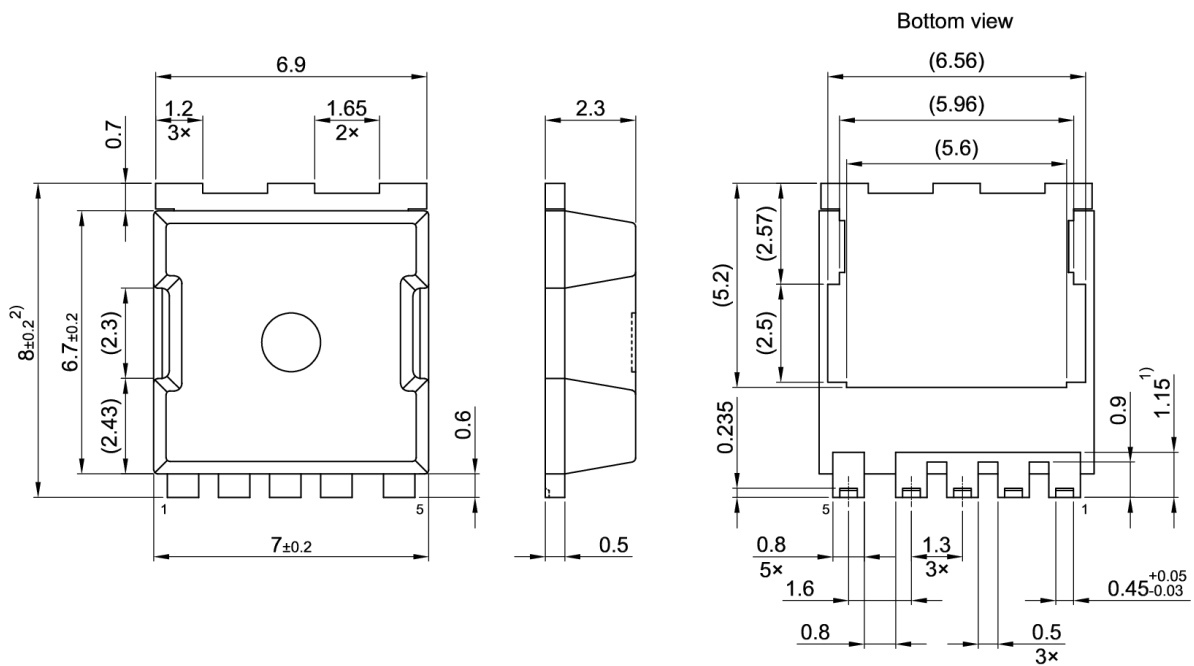
**Table 9 Unclamped inductive load test circuit**



**Table 10 Switching times test circuit for resistive load**




## 6 Package outlines



1) Lead length up to anti flash profile; mold flashes excluded.

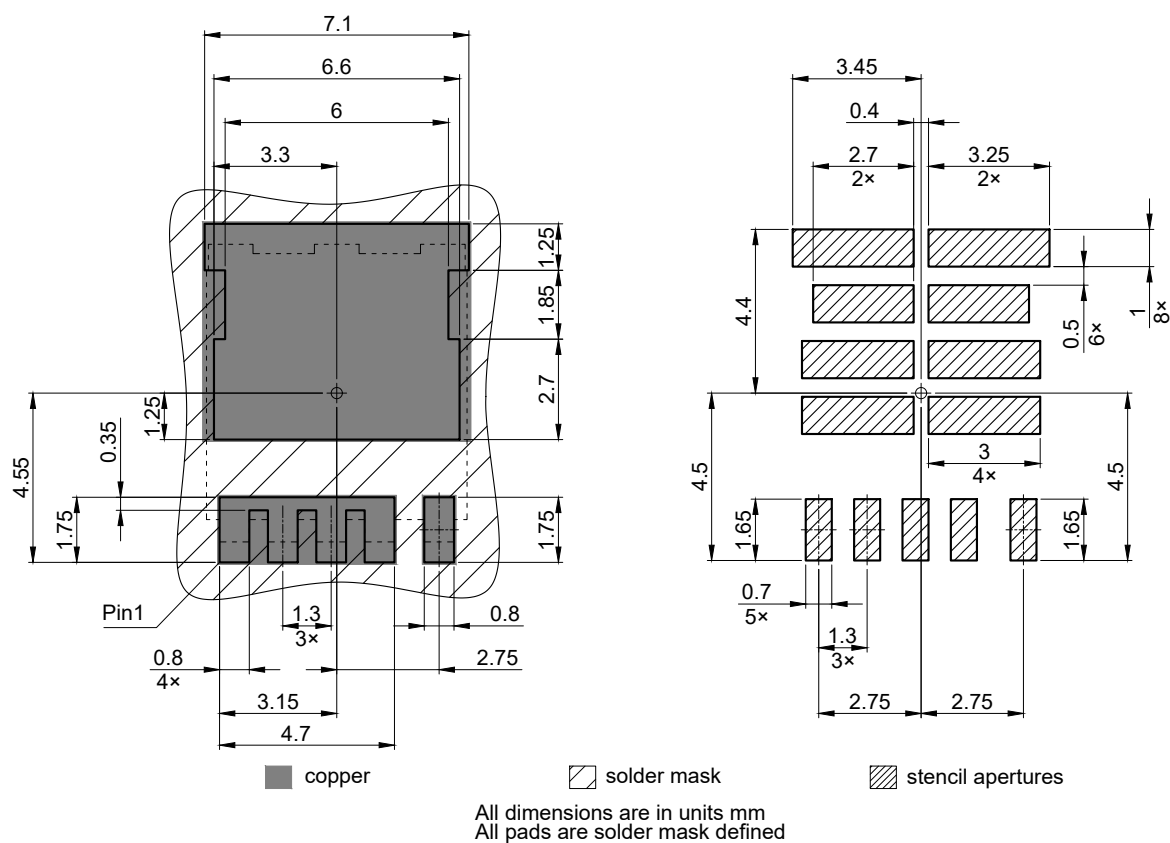
2) Excluding burr.

All dimensions are in units mm

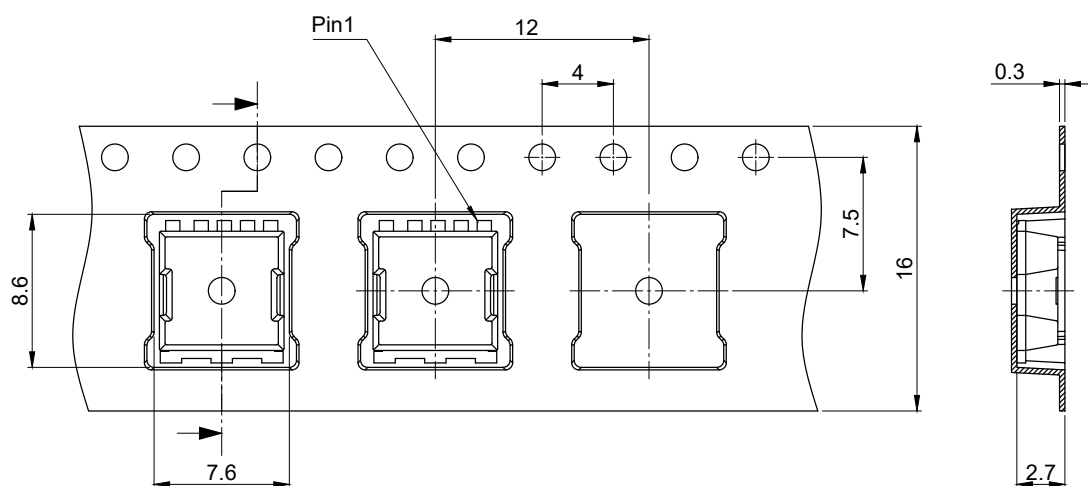
The drawing is in compliance with ISO 128-30, Projection Method 1 [  ]


Drawing according to ISO 8015, general tolerances  $\pm 0.1; \pm 1^\circ 30'$

**Figure 1** Outline PG-HSOF-5, dimensions in mm



**Figure 2 Footprint drawing PG-HSOF-5, dimensions in mm**



All dimensions are in units mm  
The drawing is in compliance with ISO 128-30, Projection Method 1 [  ]

**Figure 3** Packaging variant PG-HSOF-5, dimensions in mm

## 7 Appendix A

### Table 11 Related links

- [IFX Optimos™ Power-Transistor Webpage](#)



**Revision history**

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IAUAN04S7N014

**Revision 2026-01-14, Rev. 1.0**

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Previous revisions

Revision	Date	Subjects (major changes since last revision)
1.0	2026-01-14	Final Datasheet

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